

100V N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

| V _{(BR)DSS} | R _{DS(on)} | I _D T _A = 25°C |
|----------------------|---------------------|---|
| 100V | 85mΩ @ VGS = 10V | 7.7A |
| | 100mΩ @ Vgs = 6V | 7.1A |

Description and Applications

This MOSFET features low on-resistance, fast switching and a high avalanche withstand capability, making it ideal for high efficiency power management applications.

- DC-DC Converters
- · Power management functions
- · Disconnect switches
- Motor control
- · Uninterrupted power supply

Features and Benefits

- · Low input capacitance
- Low on-resistance
- Fast switching speed
- "Green" Component and RoHS compliant (Note 1)
- · Qualified to AEC-Q101 Standards for High Reliability

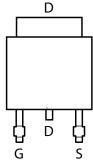
Mechanical Data

- Case: TO252-3L
- Case Material: Molded Plastic "Green" Molding Compound, UL Flammability Classification Rating 94V-0 (Note 1)
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Matte Tin Finish annealed over Copper leadframe.
 Solderable per MIL-STD-202, Method 208
- · Weight: 0.33 grams (approximate)

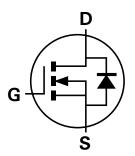




Top View



Pin Out - Top View



Equivalent Circuit

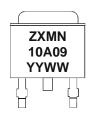
Ordering Information (Note 1)

| Product | Marking | Reel size (inches) | Tape width (mm) | Quantity per reel | |
|--------------|-----------|--------------------|-----------------|-------------------|--|
| ZXMN10A09KTC | ZXMN10A09 | 13 | 16 | 2,500 | |

1. Diodes, Inc. defines "Green" products as those which are RoHS compliant and contain no halogens or antimony compounds; further information about Diodes Inc.'s "Green" Policy can be found on our website. For packaging details, go to our website.

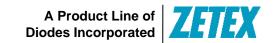
Marking Information

Notes:



ZXMN = Product Type Marking Code, Line 1 10A09 = Product Type Marking Code, Line 2 YYWW = Date Code Marking YY = Year (ex: 09 = 2009) WW = Week (01-52)





Maximum Ratings @T_A = 25°C unless otherwise specified

| Characteristic | | | Symbol | Value | Unit | |
|---|--|--|-----------------|-------------------|------|--|
| Drain-Source voltage | | | V_{DSS} | 100 | V | |
| Gate-Source voltage | | | V_{GS} | ±20 | V | |
| Continuous Drain current V _{GS} = 10V | | (Note 3) T _A = 70°C (Note 3) (Note 2) | l _D | 7.7 6.2 5.0 | А | |
| Pulsed Drain current V _{GS} = 10V | | (Note 4) | I _{DM} | 27 | Α | |
| Continuous Source current (Body diode) (Note 3) | | (Note 3) | I _S | 11 | A | |
| Pulsed Source current (Body diode) (Note 4) | | I _{SM} | 27 | A | | |

Thermal Characteristics @TA = 25°C unless otherwise specified

| Characteristic | Symbol | Value | Unit | |
|---|----------|-----------------------------------|--------------|------------|
| | (Note 2) | | 4.31 34.4 | |
| Power dissipation Linear derating factor | (Note 3) | P _D | 10.1 80.8 | W mW/°C |
| | (Note 6) | | 2.15 17.2 | |
| | (Note 2) | | 29 | |
| Thermal Resistance, Junction to Ambient | (Note 3) | $R_{	heta JA}$ | 12.3 | °C/W |
| | (Note 6) | | 58 | |
| Thermal Resistance, Junction to Lead | (Note 5) | $R_{	heta JL}$ | 1.14 | °C/W |
| Operating and storage temperature range | | T _J , T _{STG} | -55 to 150 | °C |

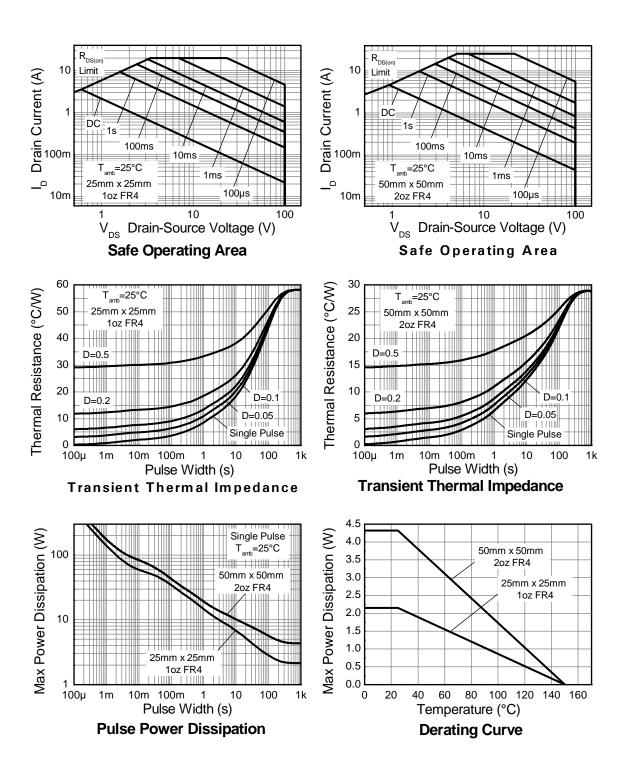
Notes:

- 2. For a device surface mounted on 50mm x 50mm x 1.6mm FR4 PCB with high coverage of single sided 2oz copper, in still air conditions; the device is measured when operating in a steady-state condition.
- 3. Same as note 2, except the device is measured at $t \le 10$ sec.
- 4. Same as note 2, except the device is pulsed with D = 0.02 and pulse width 300 µs. The pulse current is limited by the maximum junction temperature.
- 5. Thermal resistance from junction to solder-point (at the end of the drain lead).
- 6. For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with the high coverage single sided 1oz copper, in still air conditions; the device is measured when operating in a steady-state condition.

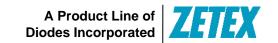




Thermal Characteristics







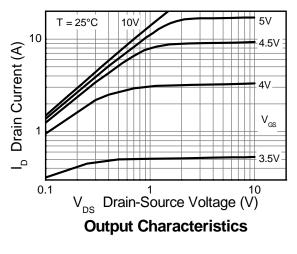
Electrical Characteristics @T_A = 25°C unless otherwise specified

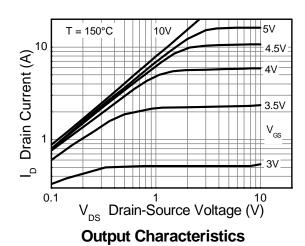
| Characteristic | Symbol | Min | Тур | Max | Unit | Test Condition | | |
|--|----------------------|-----|-------|-------|------|--|---------------------|--|
| OFF CHARACTERISTICS | | | | | | | | |
| Drain-Source Breakdown Voltage | BV _{DSS} | 100 | | _ | V | $I_D = 250 \mu A, V_{GS} = 0 V$ | | |
| Zero Gate Voltage Drain Current | I _{DSS} | _ | _ | 1 | μΑ | $V_{DS} = 100V, V_{G}$ | s = 0V | |
| Gate-Source Leakage | I _{GSS} | _ | _ | ±100 | nA | $V_{GS} = \pm 20V, V_{D}$ | s = 0V | |
| ON CHARACTERISTICS | | | | | | | | |
| Gate Threshold Voltage | V _{GS(th)} | 2 | _ | 4 | V | $I_D = 250 \mu A, V_{DS}$ | s = V _{GS} | |
| Static Drain-Source On-Resistance (Note 7) | R _{DS} (ON) | | _ | 0.085 | Ω | V _{GS} = 10V, I _D = 4.6A | | |
| Claire Brain Godree On Resistance (Note 1) | KDS (ON) | _ | | 0.100 | | V _{GS} = 6V, I _D = 4.2A | | |
| Forward Transconductance (Notes 7 & 8) | g _{fs} | _ | 10.7 | _ | S | $V_{DS} = 15V, I_D =$ | 4.6A | |
| Diode Forward Voltage (Note 7) | V_{SD} | _ | 0.850 | 0.950 | V | $I_{S} = 4.7A, V_{GS} =$ | = 0V | |
| Reverse recovery time (Note 8) | t _{rr} | _ | 40 | _ | ns | I _S = 3.0A, di/dt = 100A/μs | | |
| Reverse recovery charge (Note 8) | Q _{rr} | _ | 62 | _ | nC | | | |
| DYNAMIC CHARACTERISTICS (Note 8) | | | | | | | | |
| Input Capacitance | C _{iss} | _ | 1313 | _ | pF | 50)()(| 01/ | |
| Output Capacitance | Coss | _ | 83 | _ | pF | $V_{DS} = 50V, V_{GS}$ f = 1MHz | = UV | |
| Reverse Transfer Capacitance | C _{rss} | _ | 56 | _ | pF | 1 - 1111112 | | |
| Total Gate Charge (Note 9) | Qg | _ | 17.2 | _ | nC | $V_{GS} = 6V$ | | |
| Total Gate Charge (Note 9) | Qg | _ | 26.0 | _ | nC | | $V_{DS} = 50V$, | |
| Gate-Source Charge (Note 9) | Qgs | _ | 5.6 | _ | nC | $V_{GS} = 10V$ | $I_D = 4.6A$ | |
| Gate-Drain Charge (Note 9) | Q_{gd} | _ | 7.6 | _ | nC | | | |
| Turn-On Delay Time (Note 9) | t _{D(on)} | _ | 6.8 | _ | ns | | | |
| Turn-On Rise Time (Note 9) | t _r | _ | 5.3 | | ns | $V_{DD} = 50V, V_{GS} = 10V$ | | |
| Turn-Off Delay Time (Note 9) | t _{D(off)} | _ | 27.5 | | ns | $I_D = 1.0A, R_G \cong 25\Omega$ | | |
| Turn-Off Fall Time (Note 9) | t _f | _ | 12.3 | | ns | 1 | | |

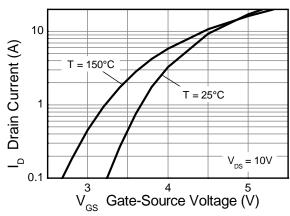
- 7. Measured under pulsed conditions. Pulse width $\leq 300 \mu s;$ duty cycle $\leq 2\%$
- 8. For design aid only, not subject to production testing.
 9. Switching characteristics are independent of operating junction temperatures.

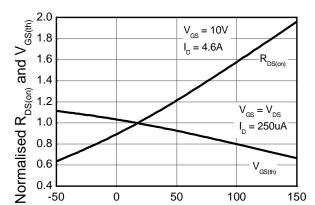


Typical Characteristics









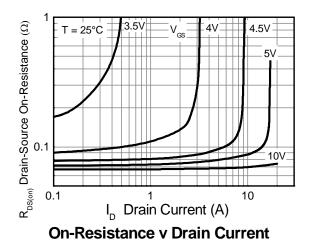


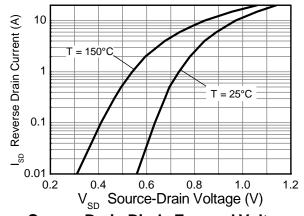


50

Tj Junction Temperature (°C)

-50



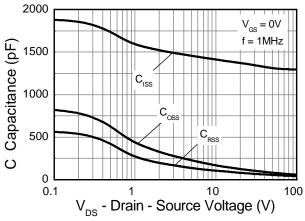


Source-Drain Diode Forward Voltage

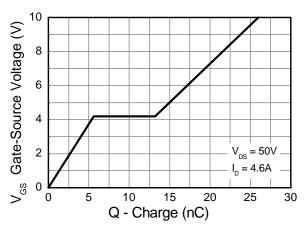
150



Typical Characteristics - continued

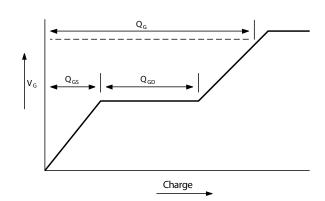


Capacitance v Drain-Source Voltage

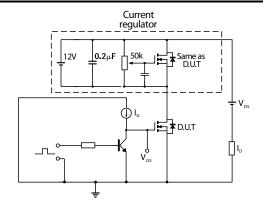


Gate-Source Voltage v Gate Charge

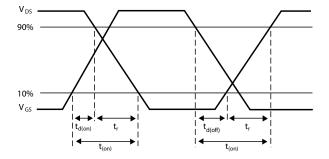
Test Circuits



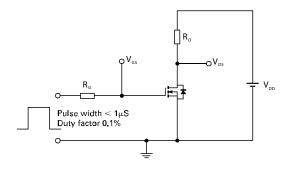
Basic gate charge waveform



Gate charge test circuit



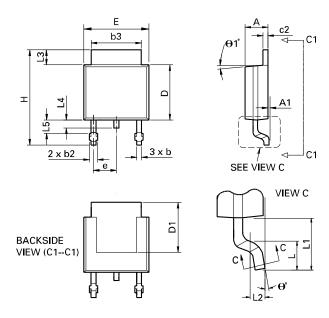
Switching time waveforms



Switching time test circuit

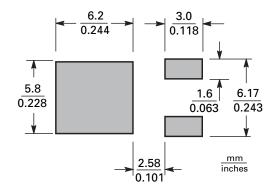


Package Outline Dimensions

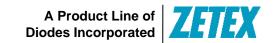


| DIM | Inches | | Millimeters | | DIM | Inches | | Millimeters | |
|------------|--------|-------|-------------|-------|-----|-----------|-------|-------------|-------|
| | Min | Max | Min | Max | | Min | Max | Min | Max |
| Α | 0.086 | 0.094 | 2.18 | 2.39 | е | 0.090 BSC | | 2.29 BSC | |
| A 1 | - | 0.005 | - | 0.127 | н | 0.370 | 0.410 | 9.40 | 10.41 |
| b | 0.020 | 0.035 | 0.508 | 0.89 | L | 0.055 | 0.070 | 1.40 | 1.78 |
| b2 | 0.030 | 0.045 | 0.762 | 1.14 | L1 | 0.108 REF | | 2.74 REF | |
| b3 | 0.205 | 0.215 | 5.21 | 5.46 | L2 | 0.020 BSC | | 0.508 BSC | |
| С | 0.018 | 0.024 | 0.457 | 0.61 | L3 | 0.035 | 0.065 | 0.89 | 1.65 |
| c2 | 0.018 | 0.023 | 0.457 | 0.584 | L4 | 0.025 | 0.040 | 0.635 | 1.016 |
| D | 0.213 | 0.245 | 5.41 | 6.22 | L5 | 0.045 | 0.060 | 1.14 | 1.52 |
| D1 | 0.205 | - | 5.21 | - | θ1° | 0° | 10° | 0° | 10° |
| Е | 0.250 | 0.265 | 6.35 | 6.73 | θ° | 0° | 15° | 0° | 15° |
| E1 | 0.170 | - | 4.32 | - | - | - | - | - | - |

Suggested Pad Layout







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